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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(use as many sheets as necessary)

Sheet	1	of	1

Complete if-Known 517657					
Application Number	Neet assigned				
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Filing Date	December 13, 2004				
First Named Inventor	Enzo DI FABRIZIO				
Art Unit	Not yet assigned				
Examiner Name	Not yet assigned				
Attorney Docket Number	Q85169				

U.S. PATENT DOCUMENTS Document Number					
Examiner Initials*	Cite No. ¹	Number	Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document
		US 2002/050711	Al	05/2/2002	Wailti, et al.
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Examiner Initials*	Cite No.1	Foreign Patent Document			Publication Date	Name of Patentee or	
		Country Code ³	Number ⁴	Kind Code ⁵ (if known)	MM-DD-YYYY	Applicant of Cited Document	Translation ⁶
		BE	1 010 200	A	03/03/1998	Variphone Benelux Naamloze Ven	
		WO	02/091920		11/21/2002	OTICON AS	
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	NON PATENT LITERATURE DOCUMENTS						
Examiner Initials*	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city, and/or country where published.					
		Xie Huikai et al.: "A SCS SMOS Micromirror for Optical Coherence Tomographic Imaging" Technical Digest., MEMS 2002 IEEE International Conference on Micro Electro Mechanical Systems, Las Vegas. NV, USA, January 20, 2002-January 24, 2002, pages 495-498, XP010577701, Piscataway, NJ, USA, ISBN: 0-7803-7185-2, pages 497-487, section "OCT application" abstract					
		J. Micromech. Microeng. 13, 2003, pages 383-389					

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